

# High-speed switching diode

## Features

1. Small surface mounting type
2. High reliability
3. High forward current capability



## Applications

High speed switch and general purpose use in computer and industrial applications

## Construction

Silicon epitaxial planar

## Absolute Maximum Ratings

$T_j=25^\circ\text{C}$

Parameter	Test Conditions	Type	Symbol	Value	Unit
Repetitive peak reverse voltage			$V_{RRM}$	50	V
Reverse voltage			$V_R$	40	V
Peak forward surge current	$t_p=1\mu\text{ s}$		$I_{FSM}$	4	A
Forward current			$I_F$	600	mA
Average forward current	$V_R=0$		$I_{FAV}$	300	mA
Power dissipation			$P_V$	500	mW
Junction temperature			$T_j$	175	?
Storage temperature range			$T_{stg}$	-65~+175	?

## Maximum Thermal Resistance

$T_j=25^\circ\text{C}$

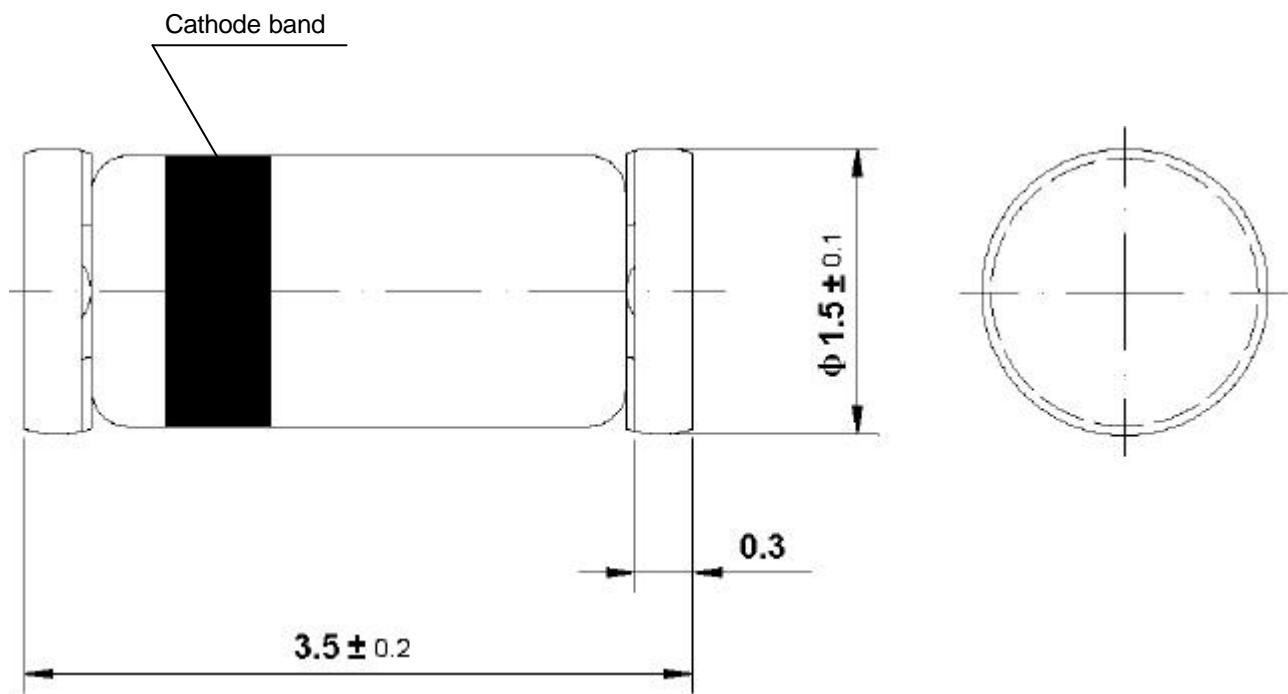
Parameter	Test Conditions	Symbol	Value	Unit
Junction ambient	on PC board 50mm× 50mm× 1.6mm	$R_{thJA}$	500	K/W

## Electrical Characteristics

$T_J=25^\circ\text{C}$

Parameter	Test Conditions	Type	Symbol	Min	Typ	Max	Unit
Forward voltage	$I_F=1\text{mA}$		$V_F$	0.54		0.62	V
	$I_F=10\text{mA}$		$V_F$	0.66		0.74	V
	$I_F=50\text{mA}$		$V_F$	0.76		0.86	V
	$I_F=100\text{mA}$		$V_F$	0.82		0.92	V
	$I_F=200\text{mA}$		$V_F$	0.87		1.0	V
Reverse current	$V_R=50\text{V}$		$I_R$			100	nA
	$V_R=50\text{V}, T_J=150^\circ\text{C}$		$I_R$			100	$\mu\text{A}$
Diode capacitance	$V_R=0, f=1\text{MHz}, V_{HF}=50\text{mV}$		$C_D$			2.5	pF
Reverse recovery time	$I_F = I_R=10\ldots100\text{mA}, i_R=1\text{mA}, R_L=1000\Omega$		$t_{rr}$			4	ns

## Dimensions in mm



Glass Case  
Mini Melf / SOD 80  
JEDEC DO 213 AA